

CL65R290F

650V N-Channel Super Junction MOSFET

Features

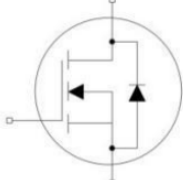
- Very Low FOM ($R_{DS(on)} \times Q_g$)
- Extremely low switching loss
- Excellent stability and uniformity
- 100% Avalanche Tested
- Built-in ESD Diode

ITEM	Value	Unit
BV_{DSS}	650	V
I_D	14	A
$R_{DS(on)(MAX)}$	0.29	Ω
$Q_{g,Typ}$	26	nC

Applications

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- AC to DC Converters
- Telecom

Package & Internal Circuit

TO-220F	SYMBOL
	

Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter	Value	Unit
V_{DSS}	Drain-Source Voltage	650	V
V_{GS}	Gate-Source Voltage	± 30	V
I_D	Drain Current - Continuous ($T_C = 25^\circ\text{C}$)	14	A
	Drain Current - Continuous ($T_C = 100^\circ\text{C}$)	11.2	A
$I_{DM}^{(1)}$	Drain Current - Pulsed	56	A
$E_{AS}^{(2)}$	Single Pulsed Avalanche Energy	175	mJ
I_{AR}	Avalanche Current	2.0	A
dv/dt	MOSFET dv/dt ruggedness, $V_{DS}=0\cdots 400\text{V}$	50	V/ns
dv/dt	Reverse diode dv/dt, $V_{DS}=0\cdots 400\text{V}$, $I_{DS}\leq I_D$	15	V/ns
P_D	Power Dissipation ($T_C = 25^\circ\text{C}$)	35	W
$V_{ESD(G-S)}$	Gate source ESD(HBM-C=100pF, R=1.5K Ω)	2000	V
T_j, T_{stg}	Operating and Storage Temperature Range	-55 to +150	$^\circ\text{C}$

Thermal Resistance Characteristics

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	3.57	$^\circ\text{C/W}$
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	$^\circ\text{C/W}$

Electrical Characteristics $T_J = 25\text{ }^{\circ}\text{C}$ unless otherwise specified

Symbol	Parameter	Test conditions	Min	Typ	Max	Unit
On-Characteristics						
V _{GS}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μ A	2.0		4.0	V
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D = 7.0A		0.25	0.29	Ω
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 1mA	650			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 650 V, V _{GS} = 0			1	μ A
		V _{DS} = 650 V, T _C = 150 °C			100	μ A
I _{GSS}	Gate-Body Leakage Current	V _{GS} = ±30 V, V _{DS} = 0 V			± 100	nA
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 100 V, V _{GS} = 0 V, f = 1.0 MHz		1126		pF
C _{oss}	Output Capacitance			41		pF
C _{rss}	Reverse Transfer Capacitance			2.4		pF
Switching Characteristics						
t _{d(on)}	Turn-On Time	V _{DS} = 400 V, I _D = 7.5A, R _G = 25 Ω (Note 3,4)		20		ns
t _r	Turn-On Rise Time			40		ns
t _{d(off)}	Turn-Off Delay Time			95		ns
t _f	Turn-Off Fall Time			43		ns
Q _g	Total Gate Charge	V _{DS} = 520 V, I _D = 7.5 A, V _{GS} = 10 V (Note 3,4)		26		nC
Q _{gs}	Gate-Source Charge			3.6		nC
Q _{gd}	Gate-Drain Charge			10.5		nC
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current				14	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current				42	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 14A			1.3	V
t _{rr}	Reverse Recovery Time	V _R = 400V, I _F =14A		405		ns
Q _{rr}	Reverse Recovery Charge	di _F /dt = 100 A/μs		4.0		μ C

Notes :

1. Repetitive Rating : Pulse width limited by maximum junction temperature
2. $I_{AS}=2.0\text{A}, V_{DD}=50\text{V}, R_G=25\Omega$, Starting $T_J = 25\text{ }^{\circ}\text{C}$
3. Pulse Test : Pulse Width $\leq 300\text{ }\mu\text{s}$, Duty Cycle $\leq 2\%$
4. Essentially Independent of Operating Temperature

Typical Characteristics

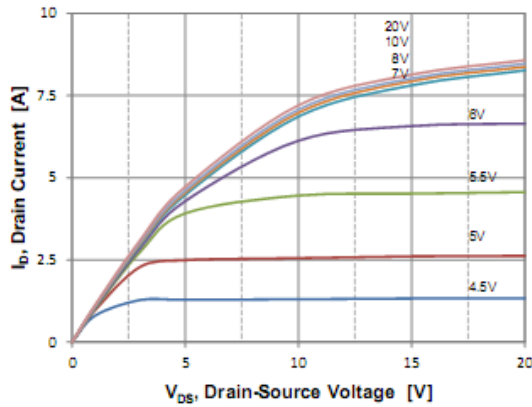


Figure 1. On Region Characteristics

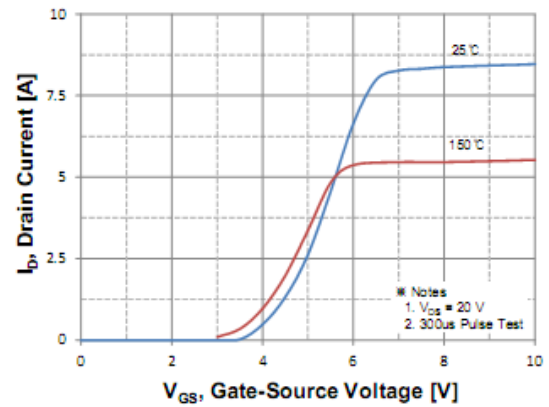


Figure 2. Transfer Characteristics

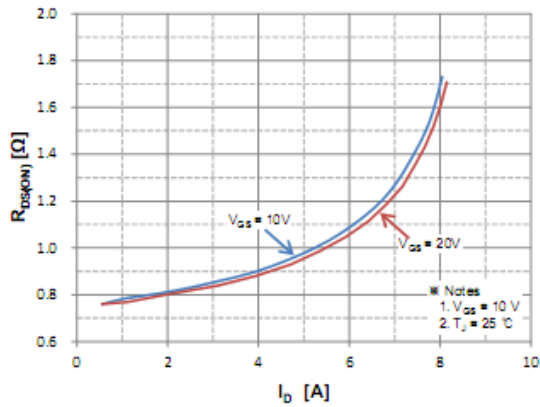


Figure 3. On Resistance Variation vs Drain Current and Gate Voltage

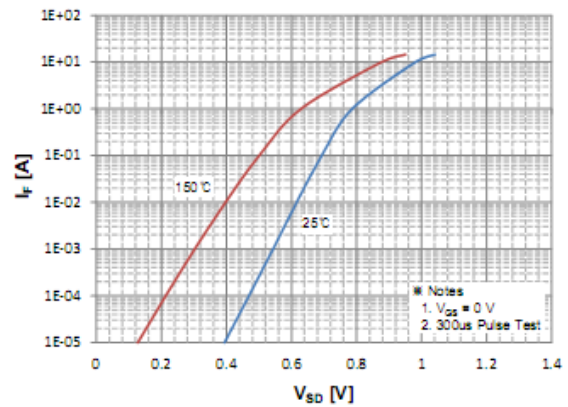


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

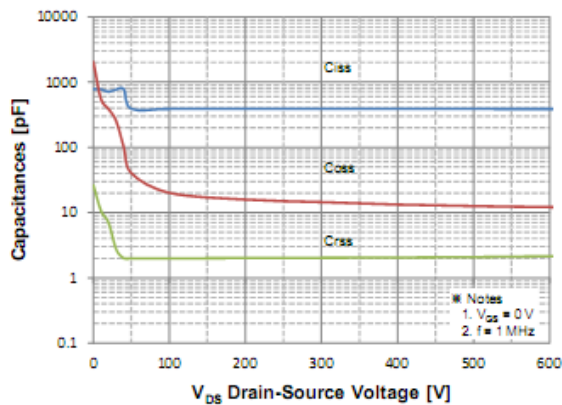


Figure 5. Capacitance Characteristics

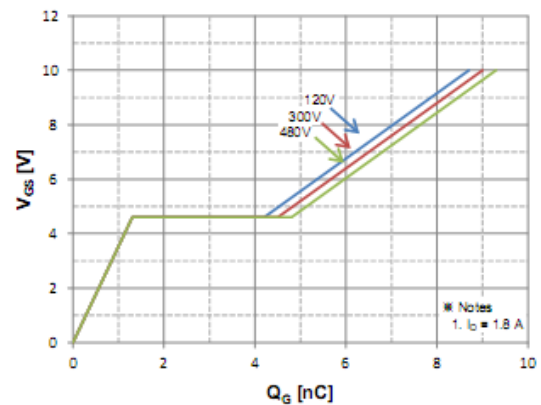


Figure 6. Gate Charge Characteristics

Typical Characteristics

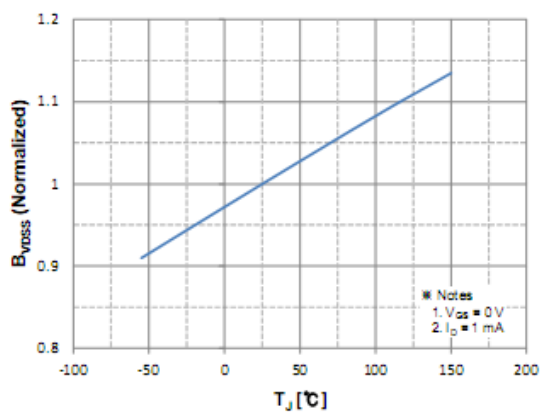


Figure 7. Breakdown Voltage Variation vs. Temperature

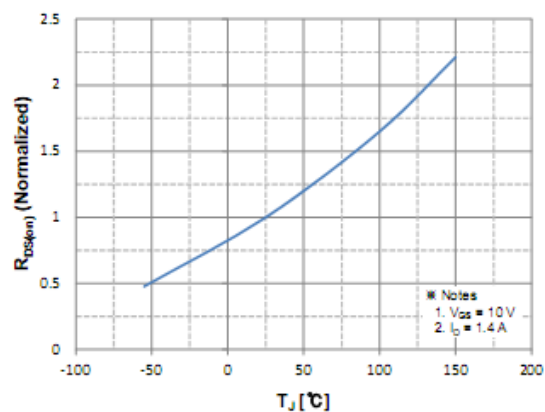


Figure 8. On-Resistance Variation vs. Temperature

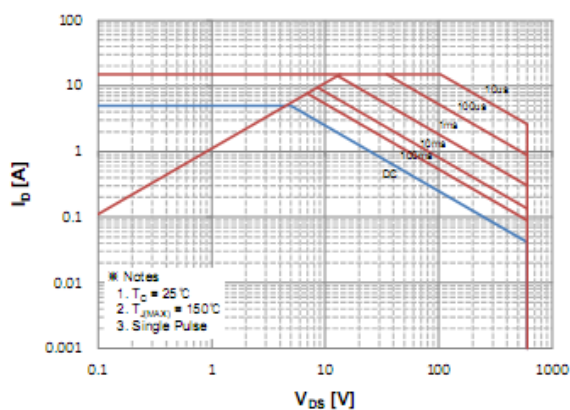


Figure 9. Maximum Safe Operating Area

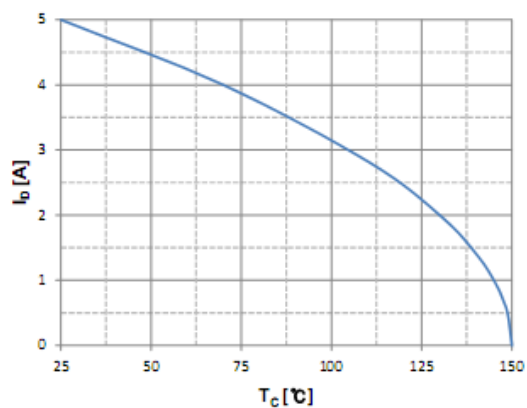


Figure 10. Maximum Drain Current vs. Case Temperature

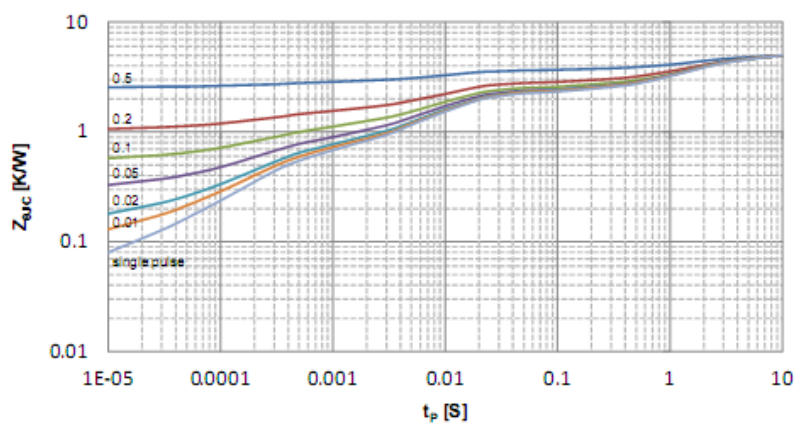


Figure 11. Transient Thermal Response Curve

Fig 12. Gate Charge Test Circuit & Waveform

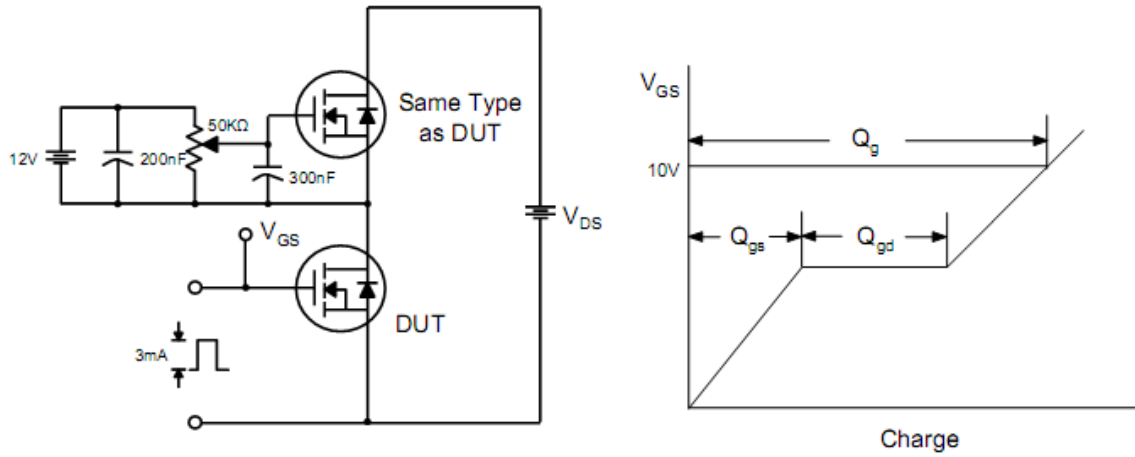


Fig 13. Resistive Switching Test Circuit & Waveforms

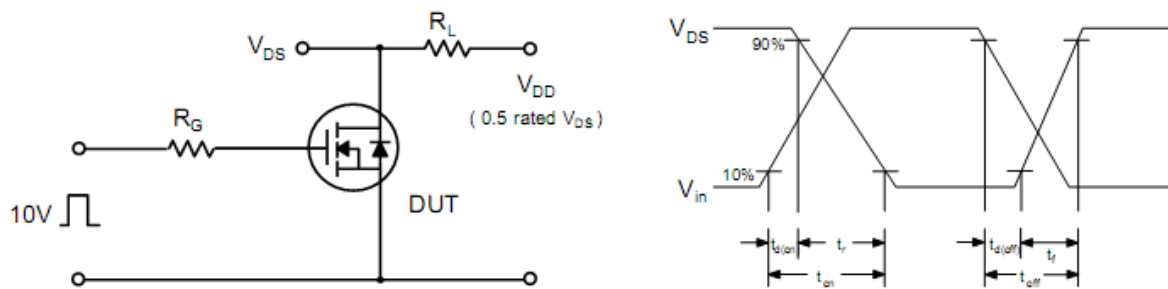


Fig 14. Unclamped Inductive Switching Test Circuit & Waveforms

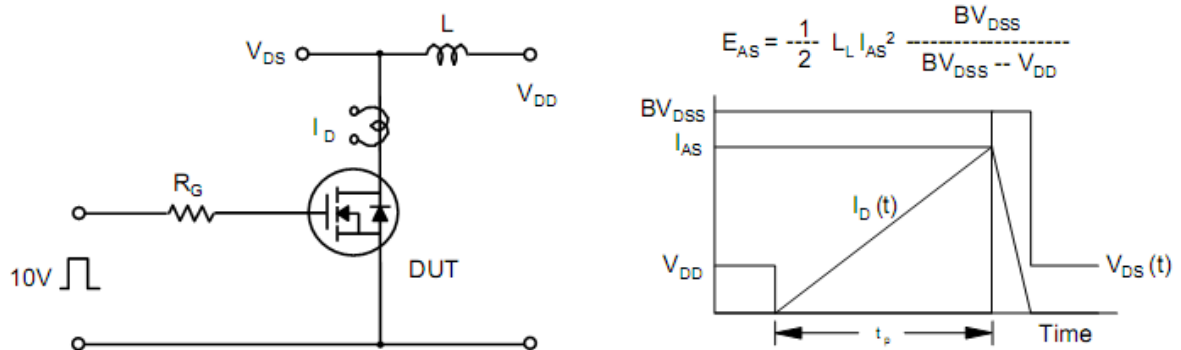
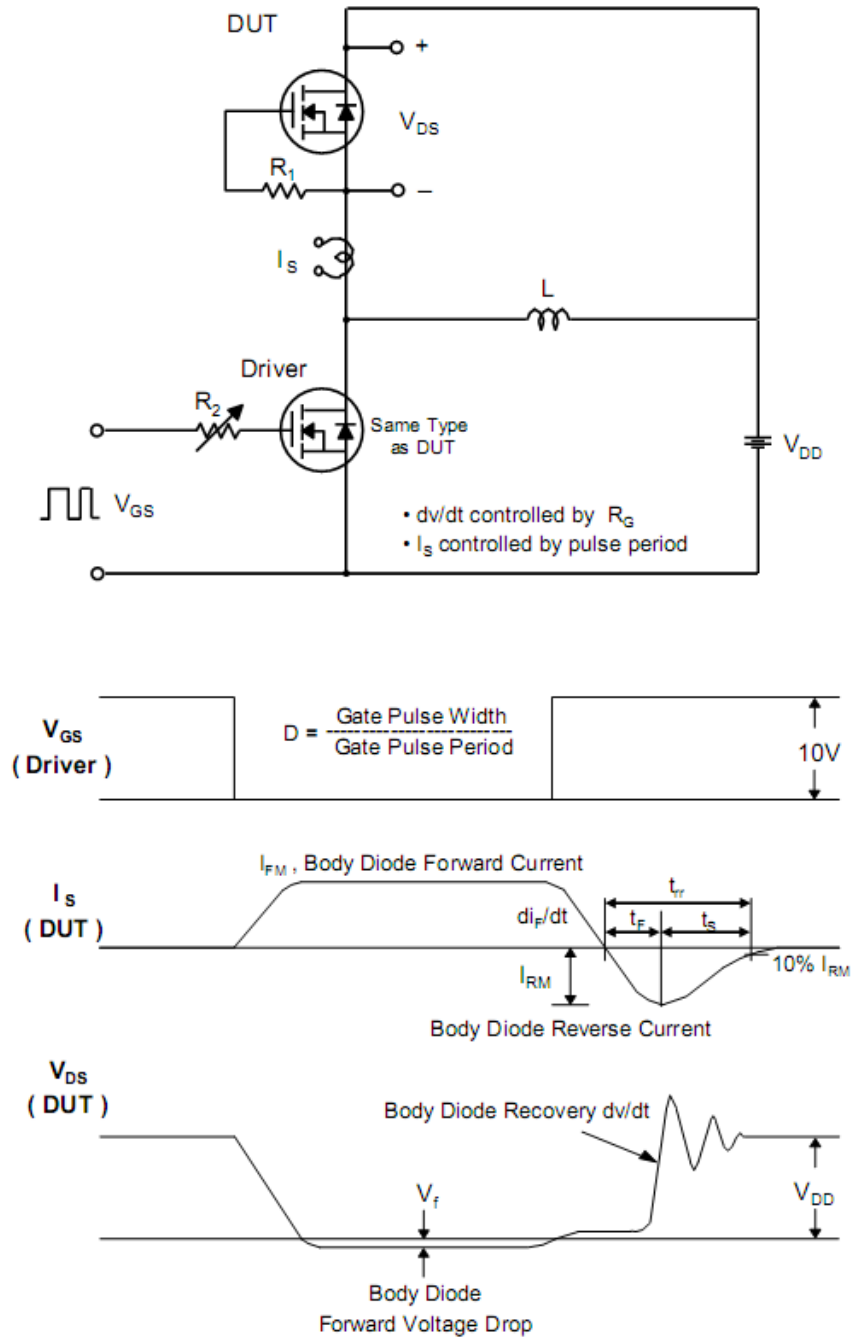
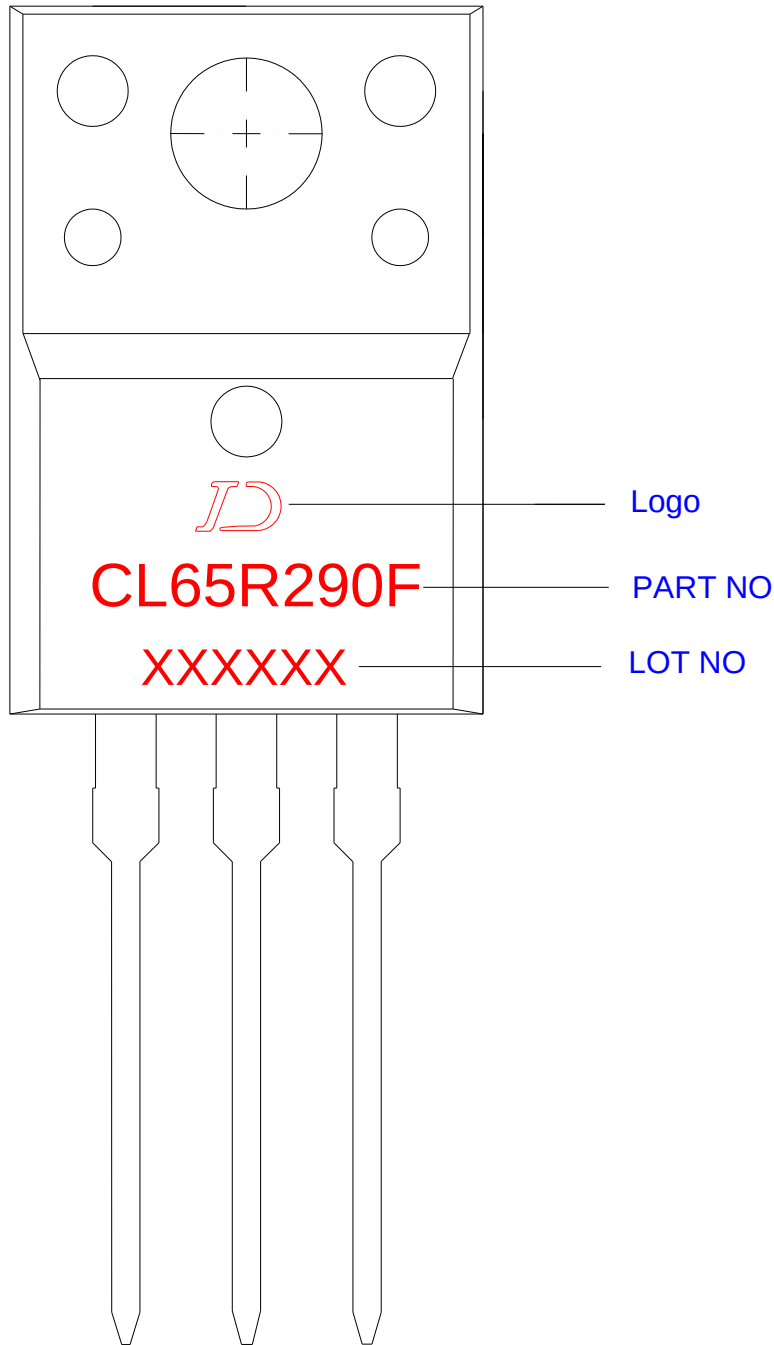


Fig 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms



Marking



Package Dimension (Unit: mm)

T0-220F

